

<b>Notice of References Cited</b>	Application/Control No. 09/832,836	Applicant(s)/Patent Under Reexamination HAN ET AL.	
	Examiner Martin J Angebranndt	Art Unit 1756	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	O	1019940006131	07-1994	Korea	Kim et al.	***
	P					
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**NON-PATENT DOCUMENTS**

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	U	Han et al., Mol. Cryst. Liq. Cryst. Vol. 327, pp. 271-274 (1999)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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